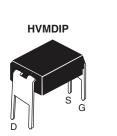
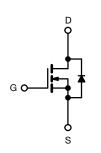


Power MOSFET





N-Channel MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	50	50				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.10				
Q _g (Max.) (nC)	24	24				
Q _{gs} (nC)	7.1	7.1				
Q _{gd} (nC)	7.1	7.1				
Configuration	Sing	Single				

FEATURES

- · For automatic insertion
- Compact, end stackable
- · Fast switching
- · Ease of paralleling
- Excellent temperature stability
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

The HVMDIP technology is the key to Vishay's advanced line of power MOSFET transistors. The efficient geometry and unique processing of the HVMDIP design achieves very low on-state resistance combined with high transconductance and extreme device ruggedness. HVMDIPs feature all of the established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling, and temperature stability of the electrical parameters.

The HVMDIP 4 pin, dual-in-line package brings the advantages of HVMDIPs to high volume applications where automatic PC board insertion is desireable, such as circuit boards for computers, printers, telecommunications equipment, and consumer products. Their compatibility with automatic insertion equipment, low-profile and end stackable features represent the stat-of-the-art in power device packaging.

ORDERING INFORMATION				
Package	HVMDIP			
Lead (Pb)-free	IRFD020PbF			

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage ^a			V _{DS}	50	.,,	
Gate-source voltage			V _{GS}	± 20	V	
Continuous drain current	V at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1	2.4		
	V _{GS} at 10 V	T _C = 100 °C	I _D	1.5	Α	
Pulsed drain current ^a			I _{DM}	19	1	
Linear derating factor				0.0080	W/°C	
Inductive current, clamped	nped L = 100 μH			19	А	
Unclamped inductive current (avalanche current) ^c			lμ	2.2	A	
Maximum power dissipation	T _C = 25 °C		P_{D}	1.0	W	
Operating junction and storage temperature range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering recommendations (peak temperature)	For 10 s			300 ^d]	

Notes

- a. $T_J = 25$ °C to 150 °C
- b. Repetitive rating; pulse width limited by maximum junction temperature
- c. V_{DD} = 25 V, starting T_J = 25 °C, L = 100 μ H, R_a = 25 Ω
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		50	-	-	V
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 \text{ V}$	-	-	± 500	nA
7 0		V_{DS} = max. rating, V_{GS} = 0 V		-	-	250	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = max. ratio	ng x 0.8, V _{GS} = 0 V, T _C = 125	-	-	1000	μA
On-State Drain Current ^b	I _{D(on)}	V _{GS} = 10 V	$V_{DS} > I_{D(on)} \times R_{DS(on)} \max$.	2.4	-	-	Α
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.4 A	-	0.080	0.10	Ω
Forward Transconductanceb	9fs	V _{DS}	= 20 V, I _D = 7.5 A	4.9	7.3	-	S
Dynamic							•
Input Capacitance	C _{iss}	V _{GS} = 0 V,		-	400	-	pF
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$		260	-	
Reverse Transfer Capacitance	C _{rss}		f = 1.0 MHz	-	44	-	1
Total Gate Charge	Qg			-	16	24	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 15 \text{ A},$ $V_{DS} = \text{max. rating x 0.8}$	-	4.7	7.1	
Gate-Drain Charge	Q _{gd}		T _{DS} a.r. raining x ore	-	4.7	7.1	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 25 \text{ V}, I_{D} = 15 \text{ A},$ $R_{g} = 18 \Omega, R_{D} = 1.7 \Omega$		-	8.7	13	- ns
Rise Time	t _r			-	55	83	
Turn-Off Delay Time	t _{d(off)}			-	16	24	
Fall Time	t _f			=	26	39	
Internal Drain Inductance	L_{D}	Between lead, 6 mm (0.25") from package and center of die contact		1	4.0	-	nH
Internal Source Inductance	L _S			-	6.0	-	11111
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	2.4	А
Pulsed Diode Forward Current ^c	I _{SM}			-	-	19	
Body Diode Voltage ^a	V _{SD}	T _C = 25 °C, I _S = 2.4 A, V _{GS} = 0 V		-	-	1.4	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 15 A, dI/dt = 100 A/μs		57	130	310	ns
Body Diode Reverse Recovery Charge	Q _{rr}			0.17	0.34	0.85	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %
- c. $\,V_{DD}$ = 25 V, starting T_{J} = 25 °C, L = 100 $\mu H,\,R_{g}$ = 25 Ω



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

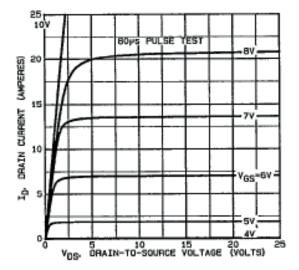


Fig. 1 - Typical Output Characteristics

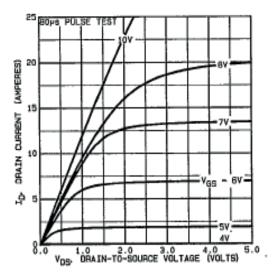


Fig. 2 - Typical Output Characteristics

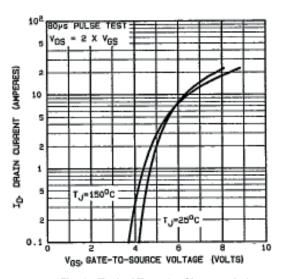


Fig. 3 - Typical Transfer Characteristics

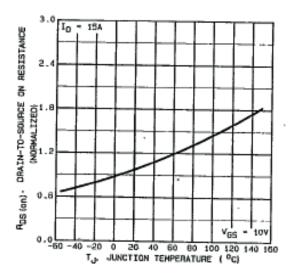


Fig. 4 - Normalized On-Resistance vs. Temperature



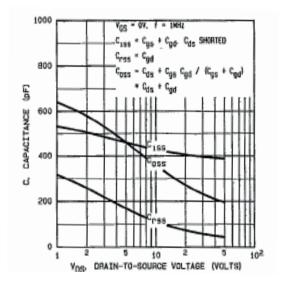


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

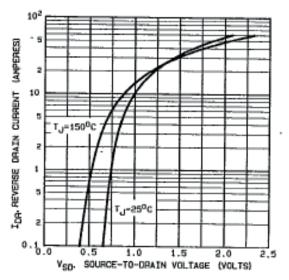


Fig. 7 - Typical Source-Drain Diode Forward Voltage

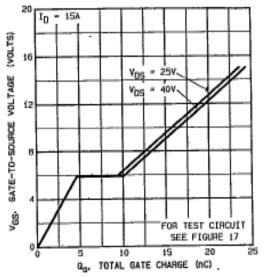


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

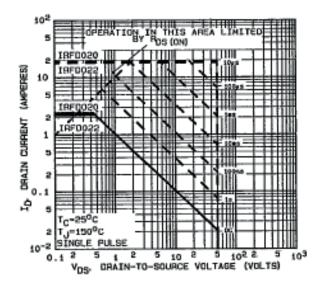


Fig. 8 - Maximum Safe Operating Area



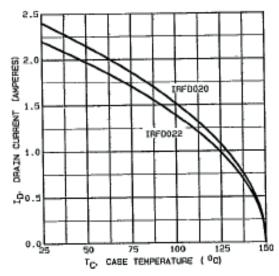


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

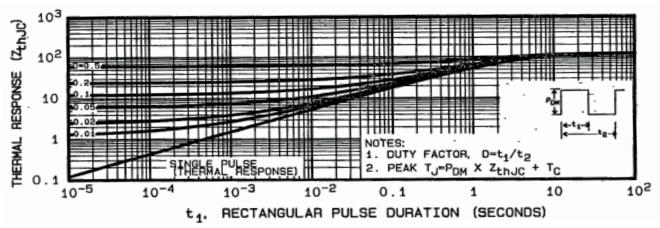


Fig. 10 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

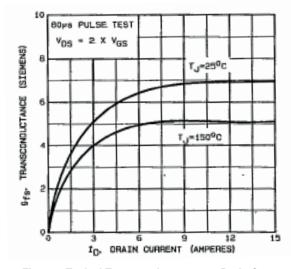


Fig. 11 - Typical Transconductance vs. Drain Current

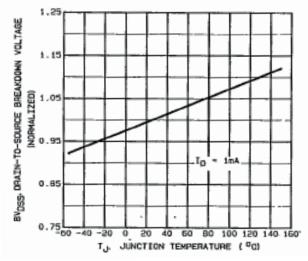


Fig. 12 - Breakdown Voltage vs. Temperature

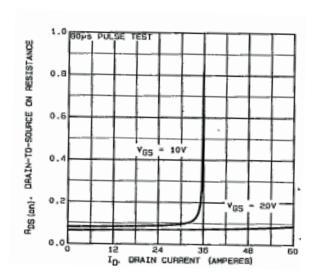


Fig. 13 - Typical on-Resistance vs. Drain Current

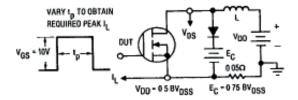


Fig. 14a - Clamped Inductive Test Circuit

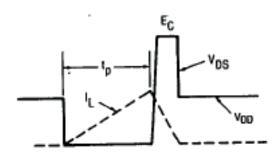


Fig. 14b - Clamped Inductive Waveforms

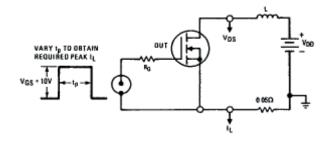


Fig. 15a - Unclamped Inductive Test Circuit

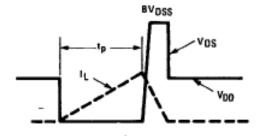


Fig. 15a - Unclamped Inductive Load Test Waveforms

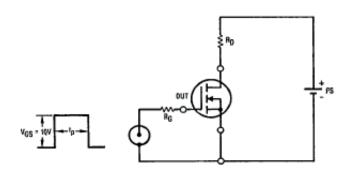


Fig. 16 - Switching Time Test Circuit

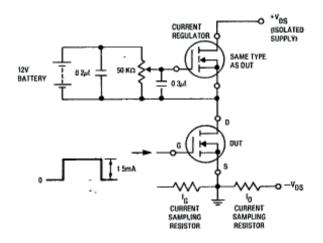
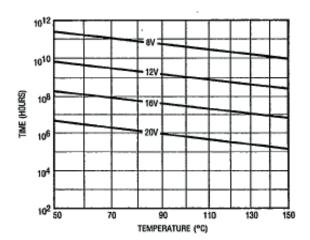


Fig. 17 - Gate Charge Test Circuit





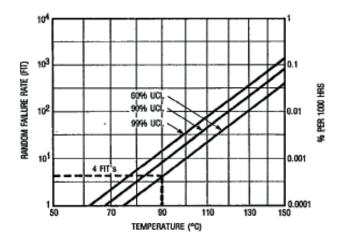


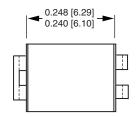
Fig. 18 - Typical Time to Accumulated 1 % Gate Failure

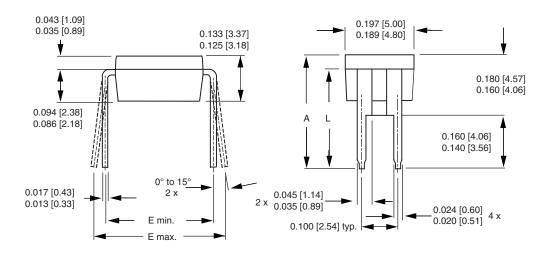
Fig. 19 - Typical High Temperature Reverse Bias (HTRB) Failure Rate

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HVM DIP (High voltage)





	INCHES		MILLIMETERS		
DIM.	MIN.	MAX.	MIN.	MAX.	
A	0.310	0.330	7.87	8.38	
Е	0.300	0.425	7.62	10.79	
L	0.270	0.290	6.86	7.36	

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10



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